Form f	orm PTO-1449 (Modified) Atty Docket No.: P18612							Serial No.: 10/809,853						
						OIP	E							
				lications		ement	Applicant: Uday Shah et al.							
(Use several sheets if necessary) / JAN 1 0 2005									Filing Date: March 24, 2004					
						<u> </u>	_,	<u> </u>						
REFER	RENC	EC	ESIGN	ATION		CAT'S TRADE	ARRES. P	ATENT DO	CUMENTS					
Examiner Initials			•	Document No.						Class	Sub- Class	Filing date if appropriate		
A	0		AA	6,642,1			Ha		11/2003	438	591			
	<u> </u>		AB AC	6,667,246 B2			Mit	suhashi et a	el. 12/2003	438	756			
	_		AD		-		+	•		<del> </del>	<del> </del>			
			AE			· · · · · · · · · · · · · · · · · · ·								
			AF AG	$\vdash$	>-		+			<del></del>	<del> </del>	<del> </del>		
			AH								<b>t</b>			
			AJ	<u> </u>										
	<del></del>		AK				╁╌				<del>                                     </del>			
			AL			-								
			AM	<del>                                     </del>			╁	<del> </del>			<del>-</del>			
			AO				$\mathbf{T}$					$\leftarrow$		
			AP											
	•					FORE	IGN	PATENT D	OCUMENTS					
No.			Docun	nent No.		Date		Country		Class	Sub-Clas	s Translation		
	AI					-								
	A													
	A		·											
	Α	U		OTHER	AD	T (Includia	- Au	ther Title	Date, Pertine	Dones.	101			
•				OTHER	. ~.	· (metaan	ıy Au	ithor, Title,	Date, Pertine	nt Pages,	etc.)			
	1	/	V											
								<del></del>						
<u> </u>		Α	W	<del></del>								·		
		A	x L											
	•	A	Y			_								
		_	Z							<u>:</u>				
Exami	ner v	1	<u>_</u> i			المننف	Date (	Considered	<i>i</i> =1.	101				
EYAM	NED	4	Cown				other	or not elter	ion is in confo	106	MOCO	Or Decuries		
through applica	h cita	tion	if not i	conform	nanc	e and not o	onsid X	dered. Inclu	ion is in conto ide copy of thi	rmance with s form with	next comm	nunication to		
							-			• • • • • • • •				
•														

12/4/06

Form P	TO-144	9 (Modi	fied) At	ty Docket N	o.: P18	612	Serial	No.: 10/8	09,853	<del>)</del>		
List of P	atents	and Pub	lications Sta		The state of	<u></u>	Applic	ant: Uda	y Shah			
(Use se	veral si	heets if n	ecessary)	l mr.		<u>ģ</u>		D-4 14				
					2 2006	4)	Filing	Date: Ma	rcn 24, 200	Д		
REFER	ENCE	DESIGN	ATION	K. Carry	S. P.	ENT DOCU	MENTS				·	
Examino Initials	er		Document	No.				Class	Sub- Class	Filir if as	ng date opropriate	198
A(	<del></del>	AA	6,255,698	B1	Gardn	er et al. 7	12001	257	369	+		12/4/06
1		AB	6,410,376	B1	Ng et	al. 6/2		438	199			144/
		AC	6,586,288		Kim e		63	438	183			
AC		AD	US 2002/0	058374 A1	Kim e	tal. 5/2	002	438	228	+		
	<u> </u>	AE			┼		-	<del> </del>	<del></del>	┽—		
		AF			+				<del>- </del>	+	· · · · · · · · · · · · · · · · · · ·	
		AG AH			1			<del>                                     </del>	+	+	<del></del>	
		AI	<del>                                     </del>			$\overline{}$		<b>†</b>	<del>                                     </del>	1-		
		AJ	-									
		AK										
		AL								1		
		AM	ļ		<del>                                     </del>				4	<b>*</b>		
		AN			<del> </del>			<del>  -</del>	<del></del>			
		AO	<u> </u>	<del></del>				<u> </u>		-		<b>.</b>
		٠		FORE	IGN PA	TENT DOC	JMENTS					· Control of the cont
		Document No. Date		C	ountry	Class	Sub-Cla	S\$	Translation			
AC	AP	-	99 784 AZ	3/3/1999				-				-
AC	AQ	GB 2	358 737 A	4/24/2001								
	AR-	<del> </del>										ā.
			OTHER A	RT (Includin	g Auth	or, Title, Da	te, Pertin	ent Pages,	, etc.)		•	
		AS										
		AT						<u>-</u>			,	
		AU										
		AV										
		AW										
		AX										
		AY								_		
					<del></del>							
Examir	ner of	(Urrys)	Hambl	1	Date Co	nsidered		5/1/04	·)			
EYANI				nsidered, wh	ether o	not citation	is in conf	ormance w	ith MPEP (	609: D	raw line	1
	h citatio	n if not i	n conformar	nce and not	conside	red. Include	copy of t	his form wit	h next com	nmuni	cation to	

Form PTO-1449 (Modified) Atty Docket No : P18612								Serial No.: 10/809,853						
List of Patents and Publications Statement									Applicant: Uday Shah et al.					
(Use se	veral	sheets if	necessar	y) [	•	Anne.								
	·				ים אות				Date: Apr	il 20, 2004	<u> </u>			
REFER	ENCE	E DESIGI	NATION	`	A SE		ENT DOCUM	ENTS						
Examin Initials	er		Docum	ent No.			•		Class	Sub- Class	Fillin if ac	g date propriate		
A	1	AĀ	6,365,4	150 B1	К	im	41200	2_	438	216				
		AB												
		AC.	_						<u> </u>		+	·		
		AE	$\rightarrow$							-	+			
		AF			$\leq$					_				
		AG												
		AH	<del></del>					_	<del> </del>		+-			
		AJ			<del>-  </del>				$\leftarrow$		+			
		AK												
		· AL									$\overline{\mathbf{A}}$			
		AM AN							<del> </del>	_	-			
		AO	-								_			
			<del></del>	<u></u>										
				F	OREIG	N PAT	ENT DOCU	MENTS				•		
			ment No. Date			Country			Class	Sub-Class Tran		Translation		
	AP	<del></del>				+				-				
	AQ					+	·							
<b></b>	I AN		OTHE	APT (Inc	ludina /	Autho	r, Title, Date	Pertin	ent Pages	etc )				
				· Ari (inc	adding /	AUU10	-, Title, Date	, resum	ent rages	, 610.)				
		46												
	$\neg F$	AS		<del></del> .										
		AT												
		AU	<del></del> -			<u> </u>								
		AV												
		214/												
		AW		<del></del>					$\overline{}$					
		AX									_			
		AY												
		AZ	- 0											
Exami	M	-lance		omleh	اج		sidered	5	1.100	0				
EXAM	NER:	Initial if	reference	considere	d, wheth	er or	not citation is	in confe	omance w	ith MPEP (	09; D	raw line		
through	h citat ant.	ion if not	in confor	mance and	not con	sidere	ed. Include c	opy of th	is form wit	n next com	munic	cation to		

12/4106

Form PTO-1449 (Modified) Ally Dockel No.: P18612 Serial No .: Umaxon 853 10/1809 List of Patents and Publications Statement Uday Shah'et al. Applicant: (Use several sheets if necessary) Filing Date: March 24, 2004 reference designation U.S. PATENT DOCUMENTS Examiner Document No. Class Sub-Filing date Initials Class if appropriate 5/2000 A-7 6,063,698 438 585 Tseng et al. 6,184,072 B1 Kaushik et al. 438 AB 2/2001 197 6,420,279 81 438 785 AC Ono et al. 7/2002 Xlang et al. AD 6,475,874 82 11/2002 438 396 6,514,828 82 Ahn et al. 212003 438 240 AE 6,544,906 82 Rotondaro et al. 4/2003 438 785 AF AG 6,617,209 B1 Chau et al. 912003 438 240 AH 6,617,210 B1 Chau et al. 9/2003 438 240 AI 6.620,713 82 Arghavani et al. 9/2-03 438 585 AJ 6,689,675 81 Parker et al. 2/2004 438 585 Brask et al. 2/2004 AK 6,696,327 B1 438 197 2/2004 AL 6,696,345 82 Chau et al. 438 387 Kizilyalli et al. 12/2002 AM US2002/0197790 A1 438 240 AN US2003/0032303 A1 Yu et al. 438 770 2/2003 AC Visokay et al. 3/2003 AO US2003/0045080 A1 438 591 FOREIGN PATENT DOCUMENTS Document No. Date Country Class Sub-Class Translation AP OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.) Polishchuk et al., "Dual Workfunction CMOS Gate Technology Based on Metal Interdiffusion", www.eesc.berkeley.edu, 1 page AQ Doug Barlage et al., "High-Frequency Response of 100nm Integrated CMOS Transistors with AR High-K Gate Dielectrics, 2001 IEEE, 4 pages Lu et al., "Dual-Metal Gate Technology for Deep-Submicron CMOS Devices", dated April 29, AS 2003, 1 page Schwantes et al., "Performance Improvement of Metal Gate CMOS Technologies with Gigabit Feature Sizes", Technical University of Hanburg-Harburg, 5 pages AT Doczy et al., "Integrating N-type and P-type Metal Gate Transistors," Serial No. 10/327,293, AU Filed December 20, 2002 Brask et al., "A Method for Making a Semiconductor Device Having a Metal Gate Electrode." ΑV Serial No. 10/704,497, Filed November 6, 2003 Brask et al., "A Method for Etching a Thin Metal Layer", Serial No. 10/704,498, Filed November AW 6, 2003 Brask et al., "A Method for Making a Semiconductor Device with a Metal Gate Electrode that is Formed on an Annealed High-K Gate Dielectric Layer", Serial No. 10/742,678, Filed 12/19/03 AX Brask et al., "A Method for Making a Semiconductor Device that Includes a Metal Gate AY Electrode", Serial No. 10/739,173, filed December 18, 2003 Brask et al., "A CMOS Device With Metal and Silicide Gate Electrodes and a Method for Making It', Serial No. 10/748,559, filed December 29, 2003 Doczy et al., "A Method for Making a Semiconductor Device that Includes a Metal Gate A Electrode°, Serial No. 10/748,545, filed December 29, 2003 Date Considered Examiner 1106 EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line

through citation if not in conformance and not considered. Include copy of this form with next communication to

Express Mail Label No.: EL 981471996 US

12/4/06

D8 1214108